# **Power MOSFET**

## 30 V, 44 A, Single N-Channel, µ8FL

### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

### Applications

- DC–DC Converters
- Power Load Switch
- Notebook Battery Management

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Param	Parameter					
Drain-to-Source Voltage	Drain-to-Source Voltage					
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V	
Continuous Drain		$T_A = 25^{\circ}C$	I <sub>D</sub>	13.3	А	
Current $R_{\theta JA}$ (Note 1)		$T_A = 80^{\circ}C$		9.9		
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	PD	2.09	W	
Continuous Drain		$T_A = 25^{\circ}C$	I <sub>D</sub>	18.2	А	
Current R <sub>θJA</sub> ≤ 10 s (Note 1)		T <sub>A</sub> = 80°C		13.6		
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	3.9	W	
Continuous Drain	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	8.2	А	
Current R <sub>0JA</sub> (Note 2)		T <sub>A</sub> = 80°C		6.1	1	
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	PD	0.79	W	
Continuous Drain		$T_{C} = 25^{\circ}C$	I <sub>D</sub>	44	А	
Current R <sub>θJC</sub> (Note 1)		$T_{\rm C} = 80^{\circ}{\rm C}$		33		
Power Dissipation $R_{\theta JC}$ (Note 1)		$T_{C} = 25^{\circ}C$	P <sub>D</sub>	23.6	W	
Pulsed Drain Current	T <sub>A</sub> = 25°0	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	128	А	
Operating Junction and S	storage Ten	nperature	T <sub>J</sub> , T <sub>stg</sub>	–55 to +150	°C	
Source Current (Body Die	ode)		۱ <sub>S</sub>	20	А	
Drain to Source dV/dt			dV/dt	6.0	V/ns	
	E <sub>AS</sub>	31	mJ			
Lead Temperature for So (1/8" from case for 10 s)	ldering Pur	poses	ΤL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum ratings. Parts are 100% tested at  $T_J = 25^{\circ}C$ ,
- $V_{GS}$  = 10 V, I<sub>L</sub> = 17 A, E<sub>AS</sub> = 14 mJ.

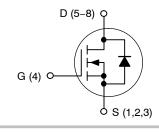


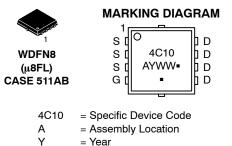
### **ON Semiconductor®**

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
30 V	7.4 mΩ @ 10 V	44 A
30 V	11 mΩ @ 4.5 V	777







(Note: Microdot may be in either location)

= Work Week = Pb-Free Package

WW

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>							
NTTFS4C10NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel							
NTTFS4C10NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel							

+ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\thetaJC}$	5.3	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	59.9	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	157.8	-C/W
Junction-to-Ambient – (t $\leq$ 10 s) (Note 4)	$R_{\theta JA}$	31.8	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

#### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition			Тур	Max	Unit
OFF CHARACTERISTICS	•			•	•	•	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> =	= 250 μA	30			V
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	V <sub>GS</sub> = 0 V, I <sub>D(ava</sub> T <sub>case</sub> = 25°C, t <sub>trans</sub>	al) = 7.1 A, ient = 100 ns	34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				14.5		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	
		$V_{DS} = 24 V$	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	; = ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μA	1.3		2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	l <sub>D</sub> = 30 A		5.9	7.4	
		V <sub>GS</sub> = 4.5 V	l <sub>D</sub> = 15 A		8.8	11	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			43		S
Gate Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°	°C		1.0		Ω
CHARGES AND CAPACITANCES				-			-
Input Capacitance	C <sub>ISS</sub>				993		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MH	z, V <sub>DS</sub> = 15 V		574		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				163		
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15	5 V, f = 1 MHz		0.164		
Total Gate Charge	Q <sub>G(TOT)</sub>				9.7		
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			1.5		nC
Gate-to-Source Charge	Q <sub>GS</sub>				2.8		
Gate-to-Drain Charge	Q <sub>GD</sub>				4.8		
Gate Plateau Voltage	V <sub>GP</sub>			3.2		V	
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 1		18.6		nC	
SWITCHING CHARACTERISTICS (Note 7)	•			•	-	-	-

Turn-On Delay Time	t <sub>d(ON)</sub>		9.0	
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,	30	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_{\rm D}$ = 15 A, R <sub>G</sub> = 3.0 $\Omega$	14	ns
Fall Time	t <sub>f</sub>		7.0	

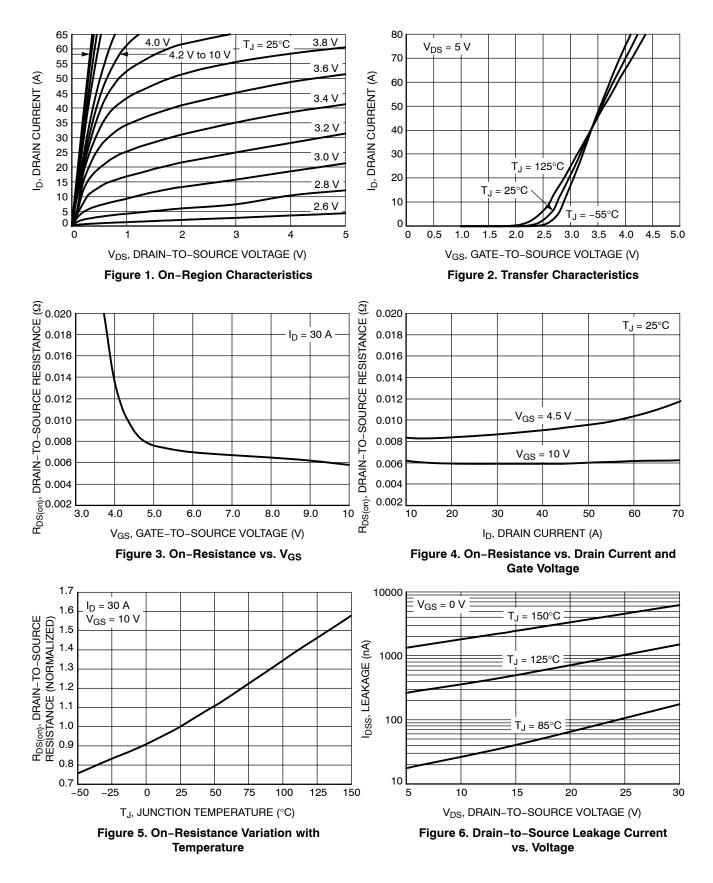
 $\begin{array}{ll} \mbox{6. Pulse Test: pulse width } \le 300 \ \mu \mbox{s, duty cycle } \le 2\%. \\ \mbox{7. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise specified)

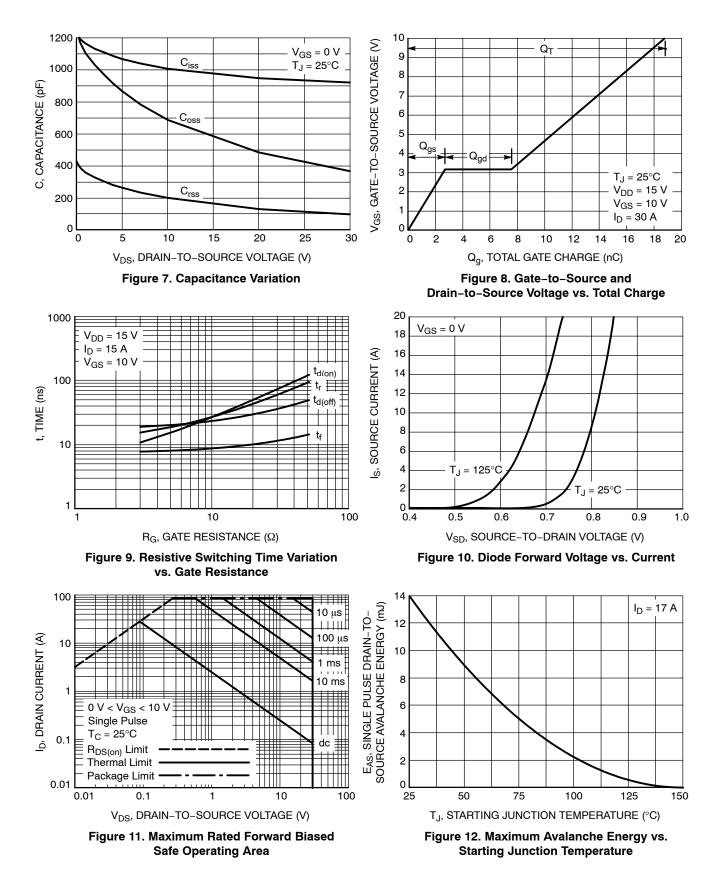
		. ,		-	-	-	
Parameter	Symbol	Test Condi	Min	Тур	Max	Unit	
SWITCHING CHARACTERISTICS (No	ote 7)						
Turn-On Delay Time	t <sub>d(ON)</sub>				6.0		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub>		25		ns	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> I <sub>D</sub> = 15 A, R <sub>G</sub> =		18			
Fall Time	t <sub>f</sub>			4.0			
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$V_{CS} = 0 V_{.}$ $T_{J} = 25^{\circ}C$		0.80	1.1	
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10 A	T <sub>J</sub> = 125°C		0.67		V
Reverse Recovery Time	t <sub>RR</sub>		•		23.3		
Charge Time	t <sub>a</sub>	$V_{GS}$ = 0 V, dIS/dt = 100 A/µs,			12.7		ns
Discharge Time	t <sub>b</sub>	I <sub>S</sub> = 30 A		10.6			
Reverse Recovery Charge	Q <sub>RR</sub>	1			8.3		nC

 $\begin{array}{ll} \mbox{6. Pulse Test: pulse width } \le 300 \ \mu \mbox{s, duty cycle } \le 2\%. \\ \mbox{7. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

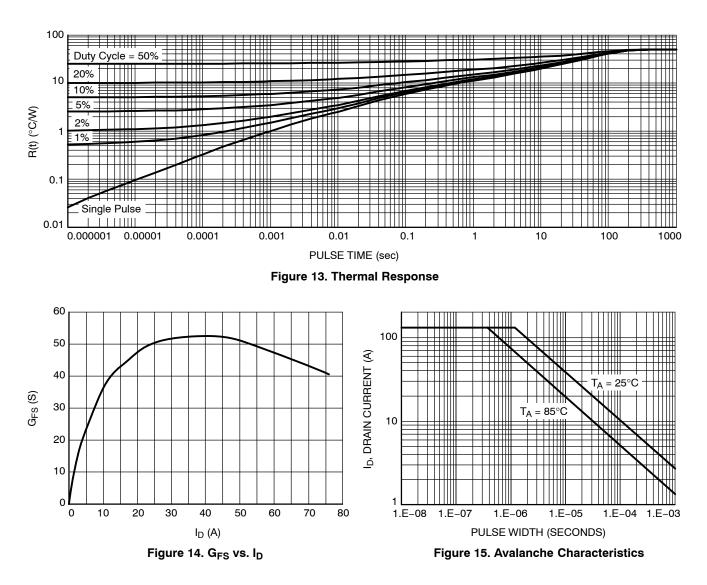
### **TYPICAL CHARACTERISTICS**



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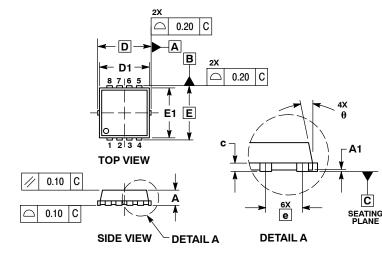


### **TYPICAL CHARACTERISTICS**



#### PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB **ISSUE D** 



8X b С AB 0.10  $\oplus$ 0.05 С e/2 4X É2 F3 М ¥ D2 G **BOTTOM VIEW** 

NOTES

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. 2

DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH RRS.

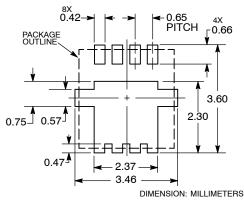
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C

	MI	LLIMETE	RS	INCHES					
DIM	MIN	NOM	MAX	MIN	NOM	MAX			
Α	0.70	0.75	0.80	0.028	0.030	0.031			
A1	0.00		0.05	0.000		0.002			
b	0.23	0.30	0.40	0.009	0.012	0.016			
с	0.15	0.20	0.25	0.006	0.008	0.010			
D		3.30 BSC		0	.130 BSC	;			
D1	2.95	3.05	3.15	0.116	0.120	0.124			
D2	1.98	2.11	2.24	0.078	0.078 0.083				
Е		3.30 BSC		0.130 BSC					
E1	2.95	3.05	3.15	0.116	0.120	0.124			
E2	1.47	1.60	1.73	0.058	0.063	0.068			
E3	0.23	0.30	0.40	0.009	0.012	0.016			
е		0.65 BSC	;	(	2				
G	0.30	0.41	0.51	0.012	0.016	0.020			
к	0.65	0.80	0.95	0.026	0.032	0.037			
L	0.30	0.43	0.56	0.012	0.017	0.022			
L1	0.06	0.13	0.20	0.002	0.005	0.008			
М	1.40	1.50	1.60	0.055	0.059	0.063			
θ	0 °		12 °	0 °		12 °			

SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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